

Features

- Uses CRM(CQ) advanced SkyMOS2 technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent $Q_g \times R_{DS(on)}$ product(FOM)
- Qualified according to JEDEC criteria

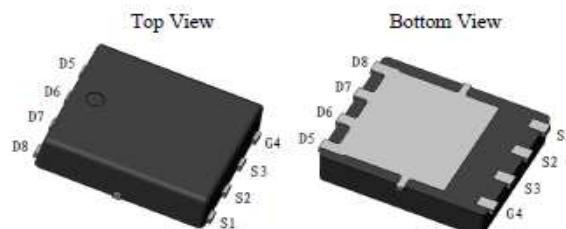
Product Summary

V_{DS}	60V
$R_{DS(on)}@10V$ typ	2.8mΩ
$R_{DS(on)}@4.5V$ typ	3.6mΩ
I_D	80A

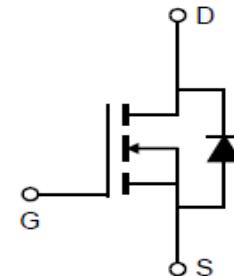
Applications

- Synchronous Rectification for AC/DC Quick Charger
- Battery management
- UPS (Uninterruptible Power Supplies)

100% Avalanche Tested



CRSM034N06L2



Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRSM034N06L2	SM034N06L2	DFN5X6	Tape&Reel	N/A	N/A	5000pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	60	V
Continuous drain current $T_C = 25^\circ\text{C}$ (Package limit) $T_C = 25^\circ\text{C}$ (Silicon limit) $T_C = 100^\circ\text{C}$ (Silicon limit)	I_D	80 117 74	A
Pulsed drain current ($T_C = 25^\circ\text{C}$, t_p limited by T_{jmax})	$I_{D\text{ pulse}}$	320	A
Avalanche energy, single pulse ($L=0.3\text{mH}$, $R_g=25\Omega$)	E_{AS}	135	mJ
Gate-Source voltage	V_{GS}	± 20	V
Power dissipation ($T_C = 25^\circ\text{C}$)	P_{tot}	79.1	W
Operating junction and storage temperature	T_j , T_{stg}	-55...+150	°C

Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – lead.	R _{thJL}	1.58	°C/W
Thermal resistance, junction – ambient	R _{thJA}	47.0	

Electrical Characteristic (at T_j = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV _{DSS}	60	66	-	V	V _{GS} =0V, I _D =250uA
Gate threshold voltage	V _{GS(th)}	1.2	1.7	2.2	V	V _{DS} =V _{GS} , I _D =250uA
Zero gate voltage drain current	I _{DSS}	-	0.02	1	μA	V _{DS} =60V, V _{GS} =0V T _j =25°C T _j =125°C
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =±20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	2.8	3.4	mΩ	V _{GS} =10V, I _D =20A
		-	3.6	4.4		V _{GS} =4.5V, I _D =20A
Transconductance	g _{fs}	-	102	-	S	V _{DS} =5V, I _D =20A

Dynamic Characteristic

Input Capacitance	C _{iss}	-	3224	-	pF	V _{GS} =0V, V _{DS} =30V, f=1MHz
Output Capacitance	C _{oss}	-	1050	-		
Reverse Transfer Capacitance	C _{rss}	-	34	-		
Gate Total Charge	Q _G	-	54.2	-	nC	V _{GS} =10V, V _{DS} =30V, I _D =20A, f=1MHz
Gate-Source charge	Q _{gs}	-	10.2	-		
Gate-Drain charge	Q _{gd}	-	7.8	-		
Turn-on delay time	t _{d(on)}	-	11.6	-	ns	V _{GS} =10V, V _{DD} =30V, R _{G_ext} =2.7Ω
Rise time	t _r	-	46.5	-		
Turn-off delay time	t _{d(off)}	-	47	-		
Fall time	t _f	-	58	-		
Gate resistance	R _G	-	2.2	-	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz



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CRSM034N06L2

SkyMOS2 N-MOSFET 60V, 2.8mΩ, 80A

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V _{SD}	-	0.78	1.2	V	V _{GS} =0V, I _{SD} =20A
Body Diode Reverse Recovery Time	t _{rr}	-	34	-	ns	I _F =20A, dI/dt=400A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	-	100	-	nC	



Typical Performance Characteristics

Fig 1: Output Characteristics

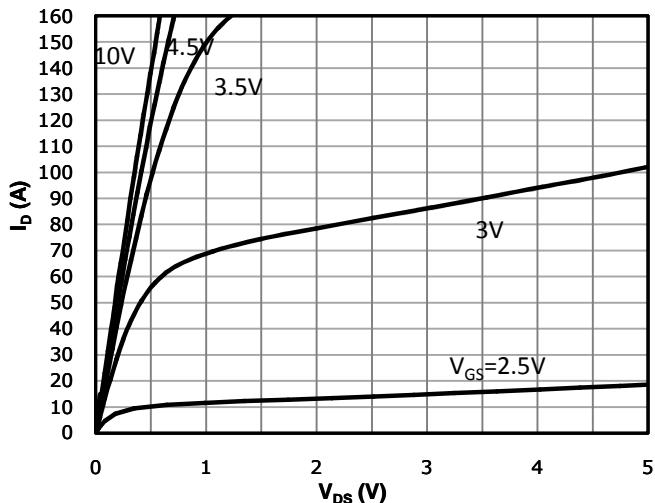


Fig 2: Transfer Characteristics

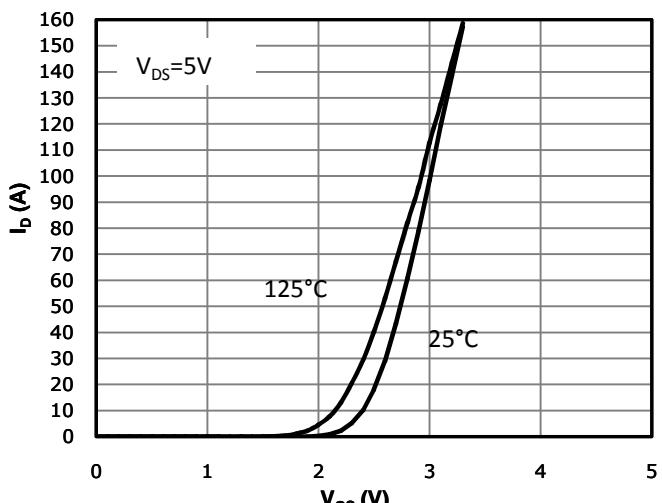


Fig 3: $R_{DS(on)}$ vs Drain Current and Gate Voltage

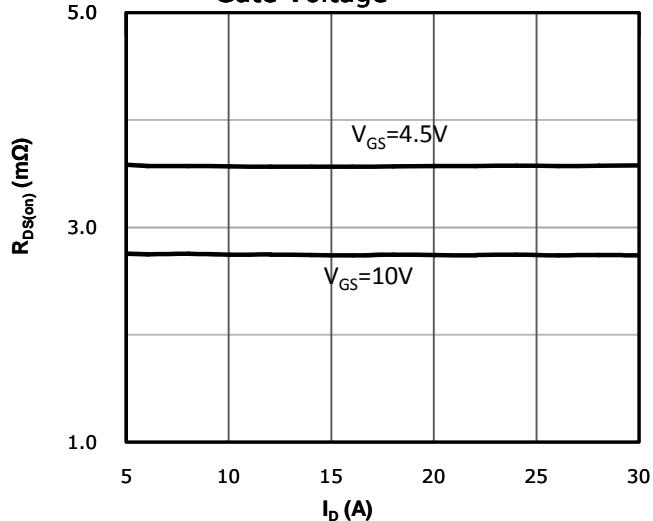


Fig 4: $R_{DS(on)}$ vs Gate Voltage

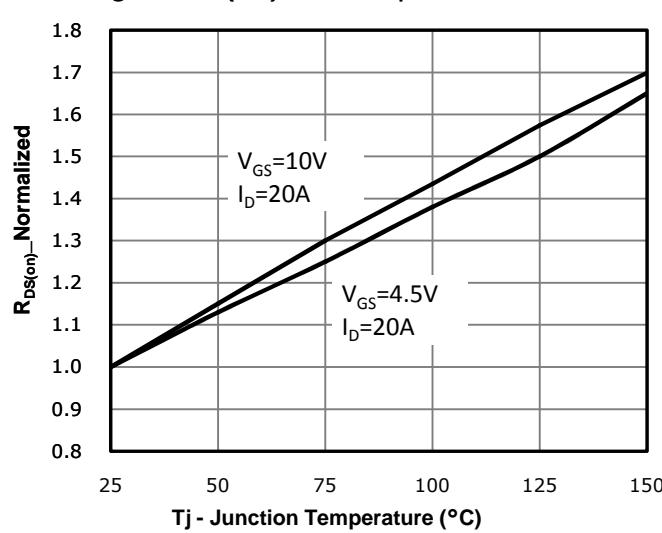
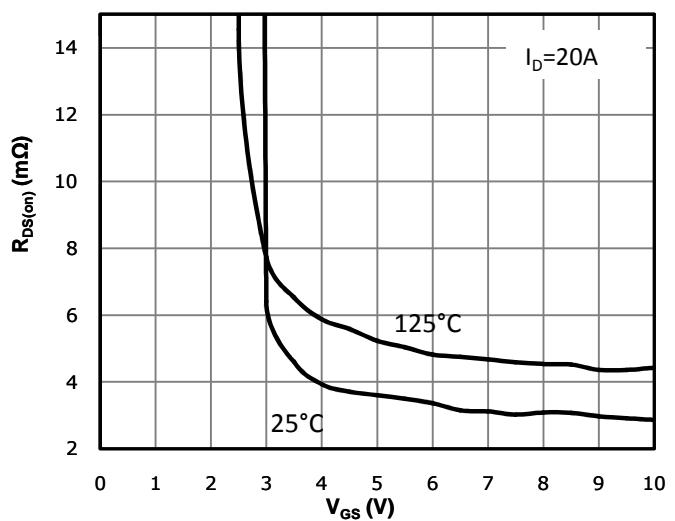


Fig 6: Capacitance Characteristics

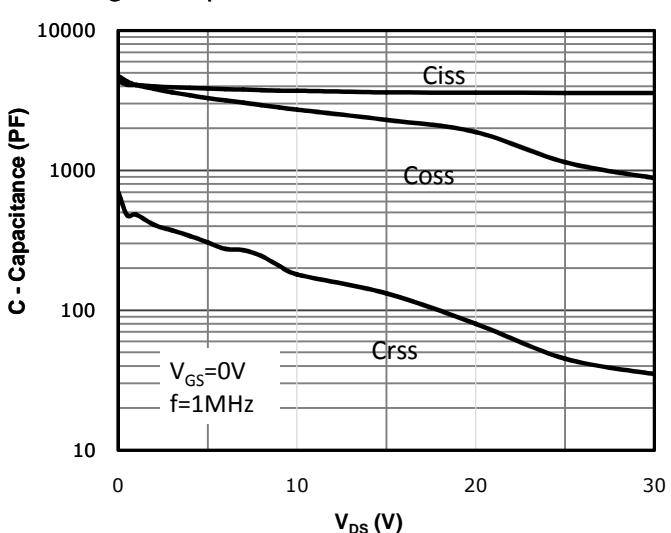


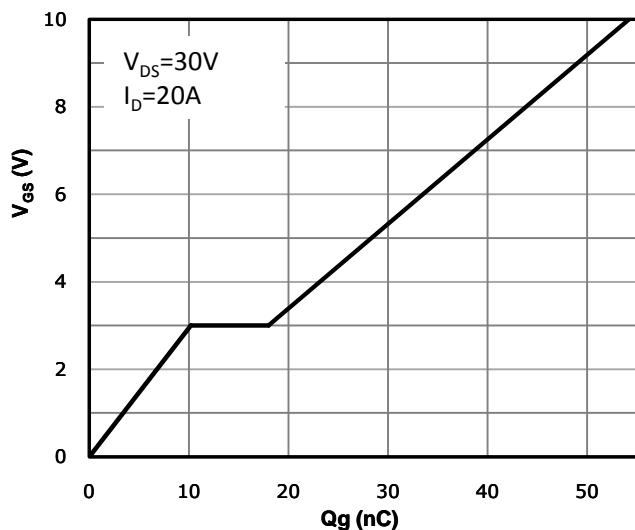
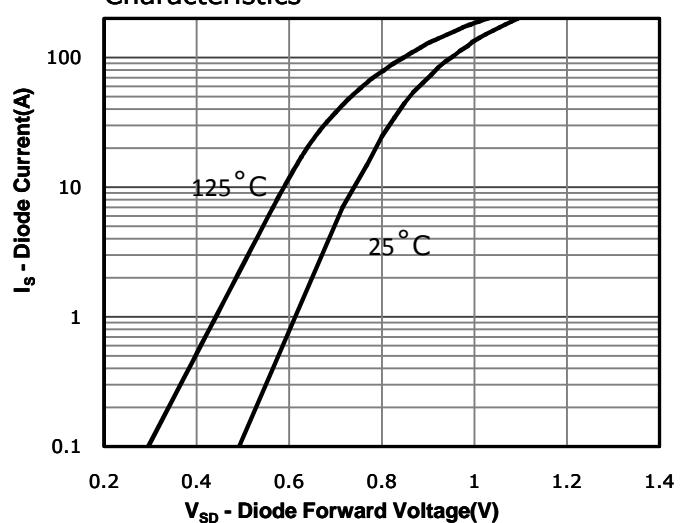
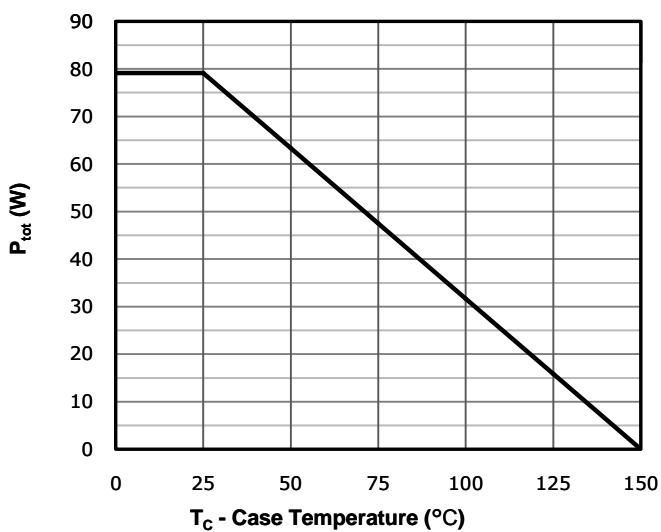
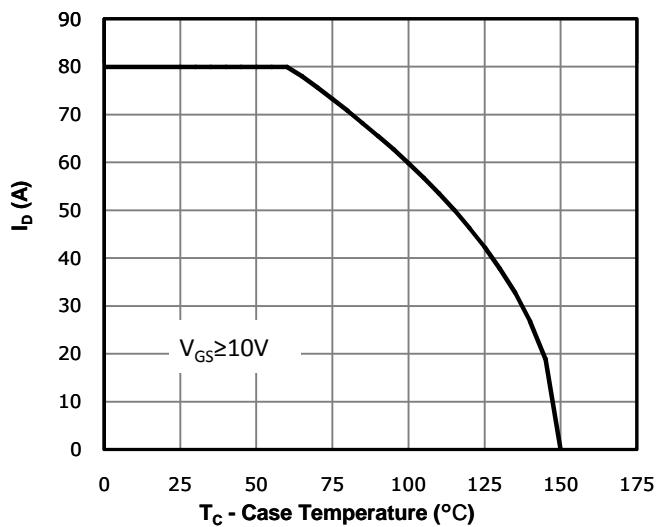
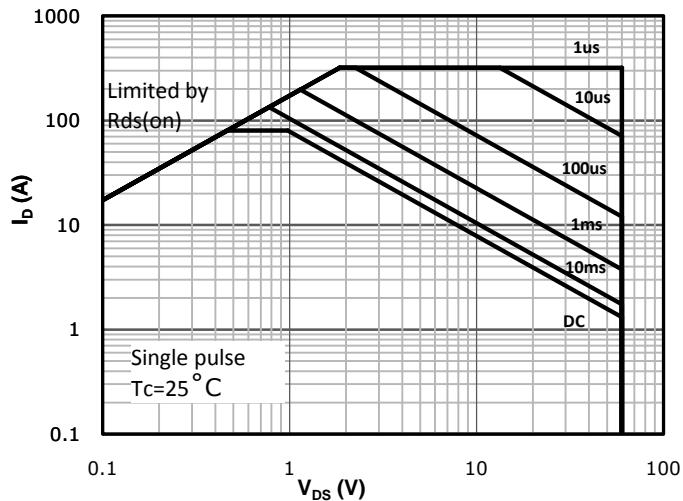
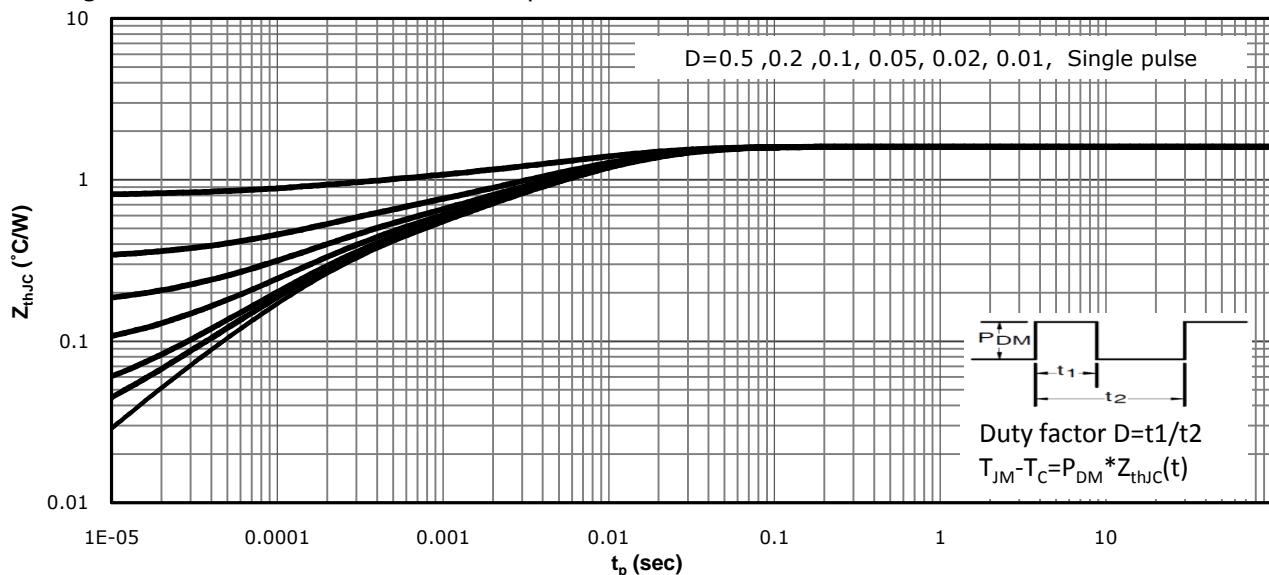
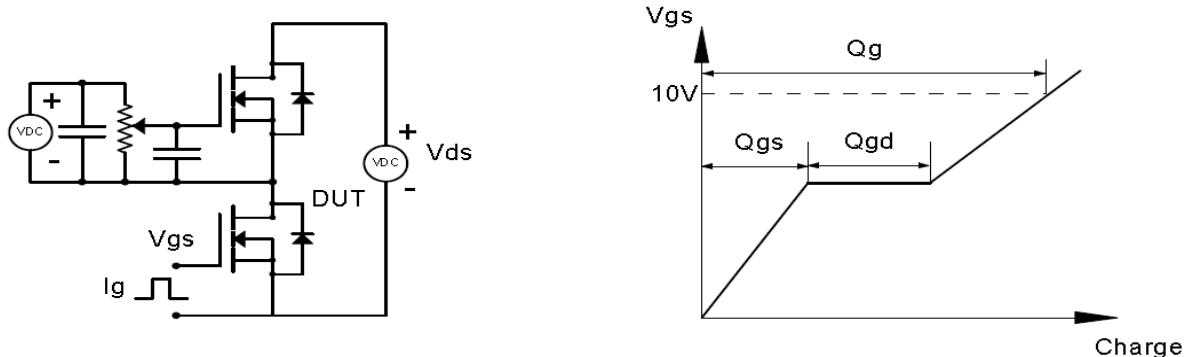
Fig 7: Gate Charge Characteristics

Fig 8: Body-diode Forward Characteristics

Fig 9: Power Dissipation

Fig 10: Drain Current Derating

Fig 11: Safe Operating Area


Fig 12: Max. Transient Thermal Impedance

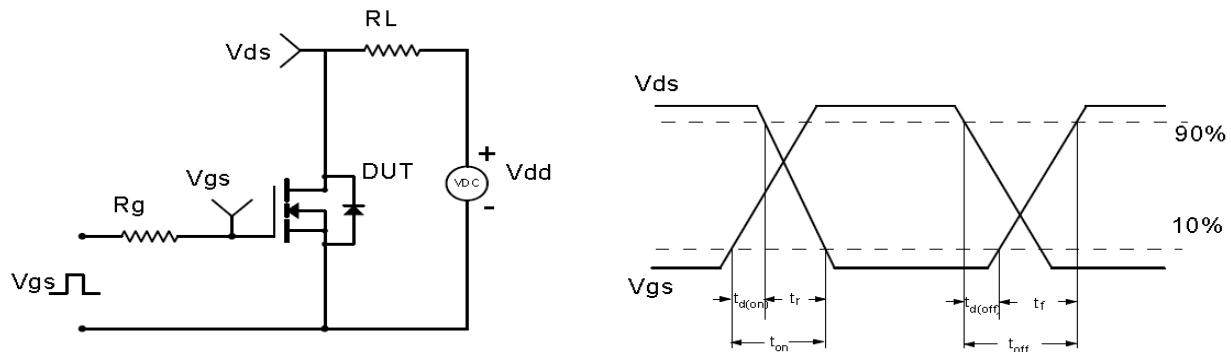


Test Circuit & Waveform

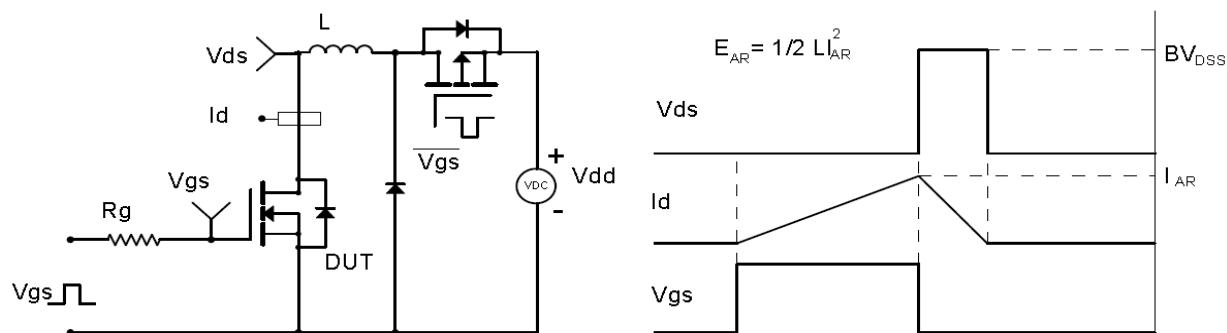
Gate Charge Test Circuit & Waveform



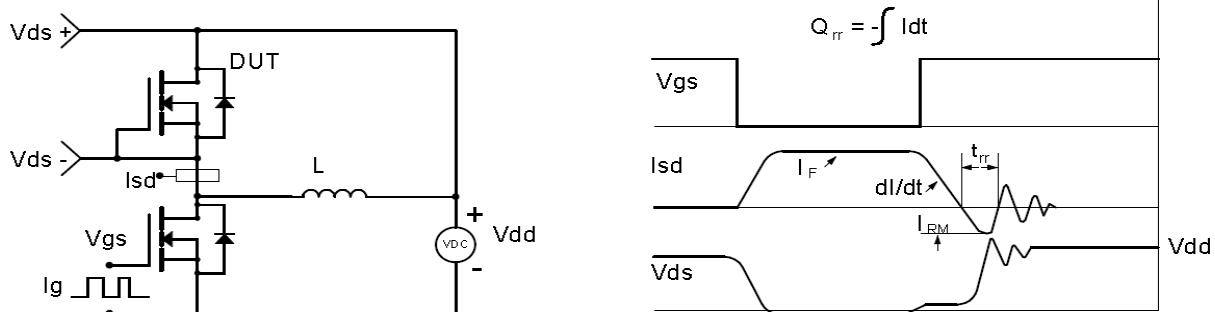
Resistive Switching Test Circuit & Waveforms



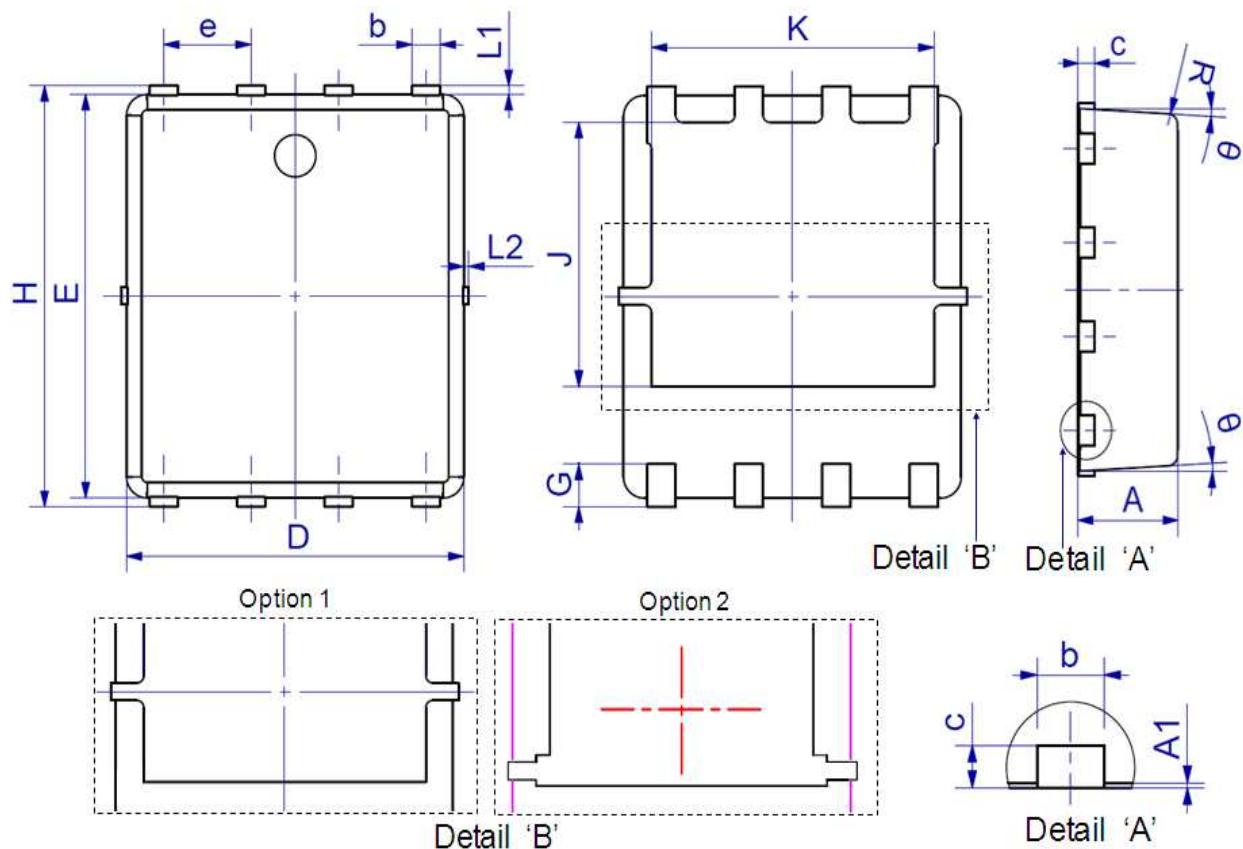
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outline: DFN5X6



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.80	1.20	0.031	0.047
A1	0.00	0.05	0.000	0.002
b	0.30	0.51	0.012	0.020
c	0.15	0.35	0.006	0.014
D	4.80	5.40	0.189	0.213
e	1.27 BSC		0.050 BSC	
E	5.66	6.06	0.223	0.239
G	0.30	0.71	0.012	0.028
H	5.90	6.35	0.232	0.250
J	3.32	3.92	0.131	0.154
K	3.61	4.25	0.142	0.167
L1	0.05	0.25	0.002	0.010
L2	0.00	0.15	0.000	0.006
R	0.25 REF		0.010 REF	
Θ	0°	12°	0°	12°



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CRSM034N06L2

SkyMOS2 N-MOSFET 60V, 2.8mΩ, 80A

Revision History

Revison	Date	Major changes
1.0	2018-5-8	Release of formal version.
1.1	2019-6-3	Revise outline size
2.0	2019-6-25	Supplement package outline info.

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.



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